

## In the United States Patent and Trademark Office

AF/ IFW

Serial Number:

10/772,053

Appn. Filed:

02/03/04

Applicant:

Guobiao Zhang

Appn. Title:

Three-Dimensional-Memory-Based Self-Test

Integrated Circuits and Methods

Examiner/GAU:

Pham, Long/2814

Mailed: April 29, 2006

## **AMENDMENT UNDER RULE 116**

Commissioner of Patents and Trademarks P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

In response to the Office Action mailed April 19, 2006, Applicant requests that the above application be amended as follows (over):

## Date of the deposit April 29, 2006

I certify that this paper is being deposited with the United States Postal Service using "First Class Mail" under 37 CFR 1.10 on the date indicated above and is addressed to "Box Non-Fee Amendments, Commissioner of Patents and Trademarks, Alexandria, VA:22313-1450."

Signed:

Guobiao Zhang